Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/743,188	MIYATA ET AL.	
Examiner	Art Unit	
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SEARCHED				
Class	Subclass	Date	Examiner	
327	156	5/31/2005	QT	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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